Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,331	HSIEH ET AL.	
Examiner	Art Unit	
James W. Cranson	2875	

SEARCHED					
Class	Subclass	Date	Examiner		
362	29	9/7/2005	JWC		
362	613	9/7/2005	JWC		
362	632-634	9/7/2005	JWC		
349	58,65	9/7/2005	JWC		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
text362/\$.CCLS.	9/6/2005	JWC	
text 349/\$.ccls.	9/6/2005	JMC	
EAST (ALL SEVEN DATA BASES)	9/6/2005	JMC	
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